

# 18NM65

**Power MOSFET**

## 18A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

### ■ DESCRIPTION

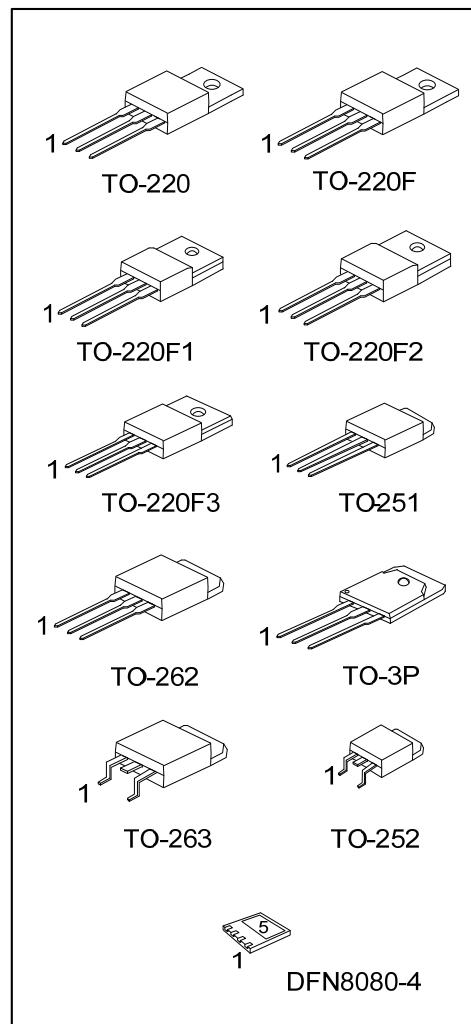
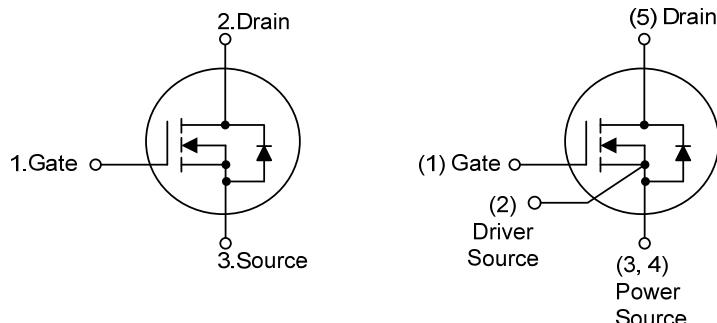
The UTC **18NM65** is a high voltage super junction MOSFET and is designed to have better characteristics.

The UTC **18NM65** Utilizing an advanced charge-balance technology, enhance system efficiency, improve EMI and reliability. such as low gate charge, low on-state resistance and have a high power density and high rugged avalanche characteristics. This super junction MOSFET usually used at AC/DC power conversion, and industrial power applications.

### ■ FEATURES

- \*  $R_{DS(ON)} \leq 0.28 \Omega$  @  $V_{GS}=10V$ ,  $I_D=9.0A$
- \* Fast Switching Capability
- \* Avalanche Energy Specified
- \* Improved dv/dt Capability, High Ruggedness

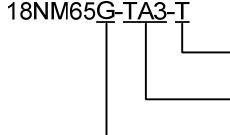
### ■ SYMBOL



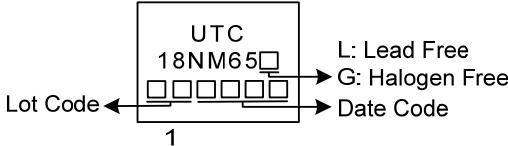
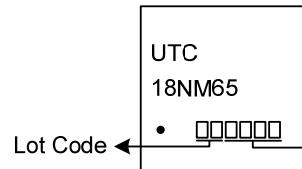
### ■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment					Packing
Lead Free	Halogen Free		1	2	3	4	5	
18NM65L-TA3-T	18NM65G-TA3-T	TO-220	G	D	S	-	-	Tube
18NM65L-TF1-T	18NM65G-TF1-T	TO-220F1	G	D	S	-	-	Tube
18NM65L-TF2-T	18NM65G-TF2-T	TO-220F2	G	D	S	-	-	Tube
18NM65L-TF3-T	18NM65G-TF3-T	TO-220F	G	D	S	-	-	Tube
18NM65L-TF3T-T	18NM65G-TF3T-T	TO-220F3	G	D	S	-	-	Tube
18NM65L-TM3-T	18NM65G-TM3-T	TO-251	G	D	S	-	-	Tube
18NM65L-TN3-R	18NM65G-TN3-R	TO-252	G	D	S	-	-	Tape Reel
18NM65L-T2Q-T	18NM65G-T2Q-T	TO-262	G	D	S	-	-	Tube
18NM65L-TQ2-T	18NM65G-TQ2-T	TO-263	G	D	S	-	-	Tube
18NM65L-TQ2-R	18NM65G-TQ2-R	TO-263	G	D	S	-	-	Tape Reel
18NM65L-T3P-T	18NM65G-T3P-T	TO-3P	G	D	S	-	-	Tube
18NM65L-K04-8080-R	18NM65G-K04-8080-R	DFN8080-4	G	S	S	S	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

 (1) Packing Type (2) Package Type (3) Green Package	(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TF1: TO-220F1, TF2: TO-220F2, TF3: TO-220F, TF3T: TO-220F3, TM3: TO-251, TN3: TO-252, T2Q: TO-262, TQ2: TO-263, T3P: TO-3P, K04-8080: DFN8080-4 (3) G: Halogen Free and Lead Free, L: Lead Free
--	---

### ■ MARKING

TO-220 / TO-220F / TO-220F1 TO-220F2 / TO-220F3 / TO-251 TO-252 / TO-262/TO-263 / TO-3P	DFN8080-4
 Lot Code ← 1 → Date Code L: Lead Free G: Halogen Free	 Lot Code ← • → Date Code

■ ABSOLUTE MAXIMUM RATINGS ( $T_c = 25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage	$V_{DSS}$	650	V	
Gate-Source Voltage	$V_{GSS}$	$\pm 30$	V	
Drain Current	Continuous	$I_D$	18	A
	Pulsed (Note 2)	$I_{DM}$	36	A
Avalanche Current (Note 2)	$I_{AR}$	2.9	A	
Avalanche Energy	Single Pulsed (Note 3)	$E_{AS}$	151	mJ
	Repetitive	$E_{AR}$	0.44	mJ
Drain Source Voltage Slope	$dv/dt$	12.9	V/ns	
Peak Diode Recovery $dv/dt$ (Note 4)		6.0	V/ns	
Power Dissipation	TO-220/TO-262/TO-263	$P_D$	104	W
	TO-220F/TO-220F1		33	W
	TO-220F2/TO-220F3		83	W
	TO-251/TO-252		200	W
	TO-3P		62	W
	DFN8080-4		+150	°C
Junction Temperature	$T_J$	-55 ~ +150	°C	
Storage Temperature	$T_{STG}$		°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3.  $L = 10\text{mH}$ ,  $I_{AS} = 5.5\text{A}$ ,  $V_{DD} = 50\text{V}$ ,  $R_G = 25\ \Omega$ , Starting  $T_J = 25^\circ\text{C}$

4.  $I_{SD} \leq 18\text{A}$ ,  $di/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	$\theta_{JA}$	62.5	°C/W
		110	°C/W
		40	°C/W
		35	°C/W
		1.2	°C/W
		3.78	°C/W
Junction to Case	$\theta_{JC}$	1.5 (Note)	°C/W
		0.625	°C/W
		2	°C/W

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

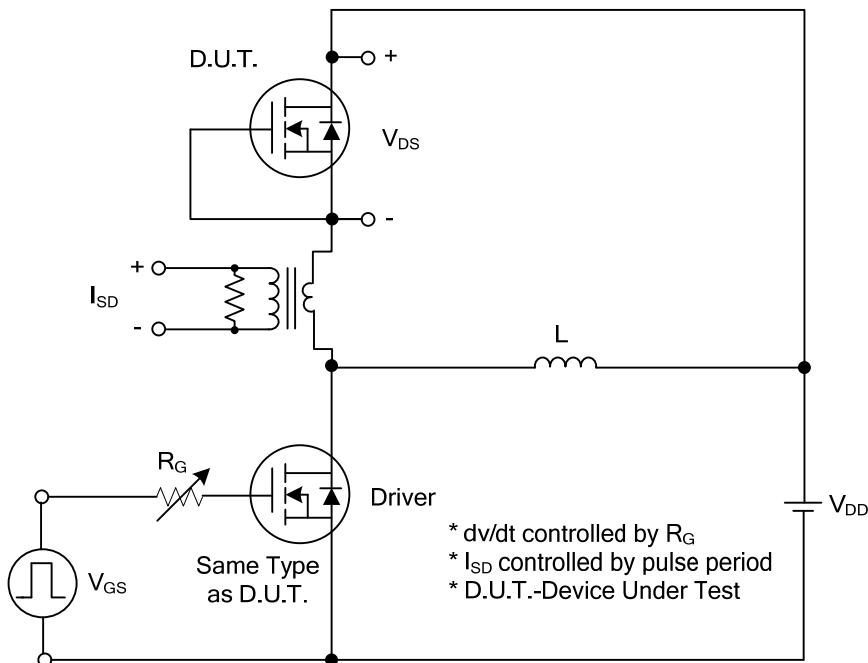
■ ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	650			V
Drain-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}}=650\text{V}, V_{\text{GS}}=0\text{V}$			10	$\mu\text{A}$
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=\pm 30\text{V}$			$\pm 100$	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{\text{GS}(\text{TH})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.5		4.5	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=9.0\text{A}$		0.23	0.28	$\Omega$
<b>DYNAMIC PARAMETERS</b>						
Input Capacitance	$C_{\text{ISS}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=50\text{V}, f=1.0\text{MHz}$		1115		pF
Output Capacitance	$C_{\text{OSS}}$			134		pF
Reverse Transfer Capacitance	$C_{\text{RSS}}$			4.9		pF
Gate Resistance	$R_{\text{G}}$	$f=1\text{MHz}$ , Open Drain			5	$\Omega$
<b>SWITCHING PARAMETERS</b>						
Total Gate Charge (Note 1)	$Q_{\text{G}}$	$V_{\text{DS}}=520\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=18\text{A}, I_{\text{G}}=1\text{mA}$ (Note 1, 2)		44		nC
Gate Source Charge	$Q_{\text{GS}}$			13		nC
Gate Drain Charge	$Q_{\text{GD}}$			17		nC
Turn-ON Delay Time (Note 1)	$t_{\text{D}(\text{ON})}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=18\text{A}, R_{\text{G}}=25\Omega$ (Note 1, 2)		18		ns
Turn-ON Rise Time	$t_{\text{R}}$			25		ns
Turn-OFF Delay Time	$t_{\text{D}(\text{OFF})}$			50		ns
Turn-OFF Fall-Time	$t_{\text{F}}$			76		ns
<b>SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS</b>						
Maximum Continuous Drain-Source Diode Forward Current	$I_{\text{S}}$				18	A
Maximum Pulsed Drain-Source Diode Forward Current	$I_{\text{SM}}$				36	A
Drain-Source Diode Forward Voltage (Note 1)	$V_{\text{SD}}$	$I_{\text{F}}=I_{\text{S}}, V_{\text{GS}}=0\text{V}$			1.5	V
Reverse Recovery Time (Note 1)	$t_{\text{rr}}$	$I_{\text{S}}=18\text{A}, V_{\text{GS}}=0\text{V}, dI_{\text{F}}/dt=100\text{A}/\mu\text{s}$		420		ns
Reverse Recovery Charge	$Q_{\text{rr}}$			7.0		$\mu\text{C}$

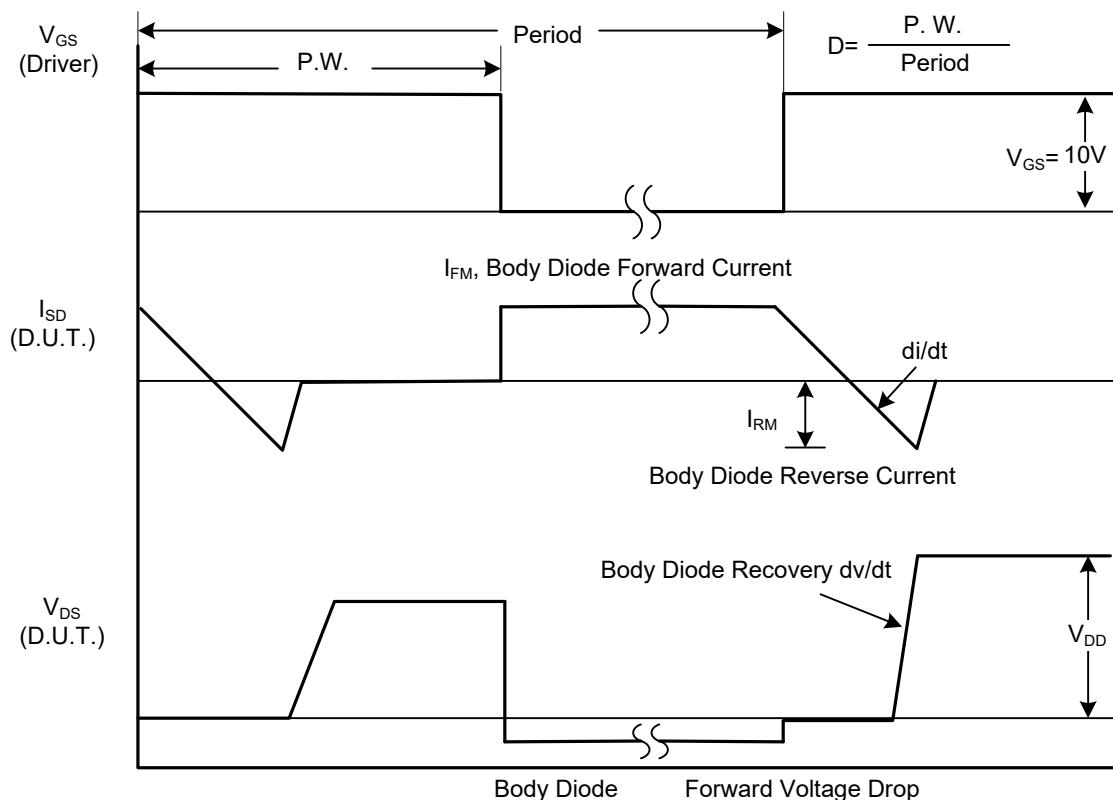
Notes: 1. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ .

2. Essentially independent of operating ambient temperature.

■ TEST CIRCUITS AND WAVEFORMS

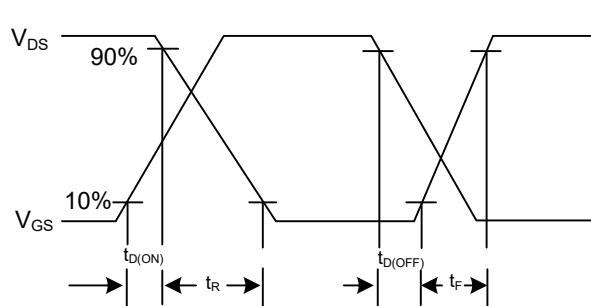
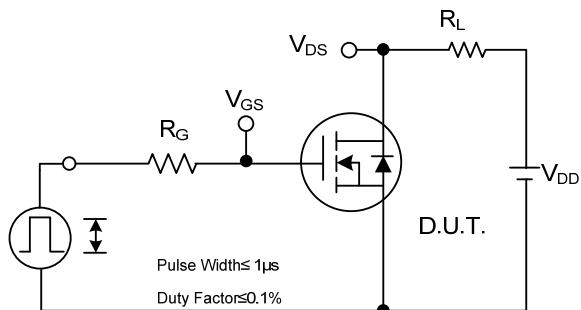


**Peak Diode Recovery dv/dt Test Circuit**



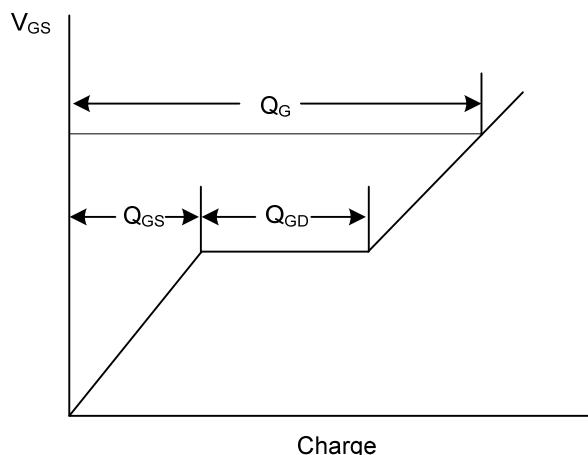
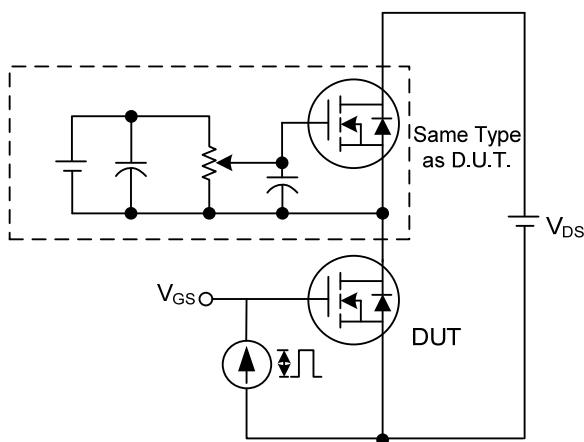
**Peak Diode Recovery dv/dt Waveforms**

■ TEST CIRCUITS AND WAVEFORMS



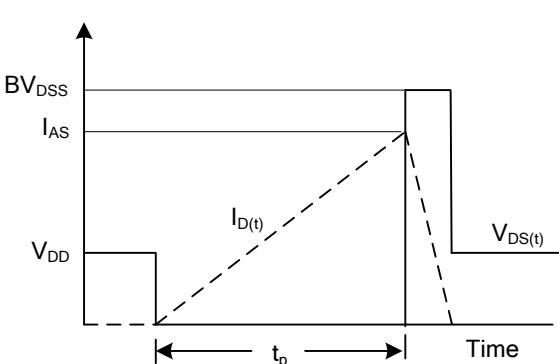
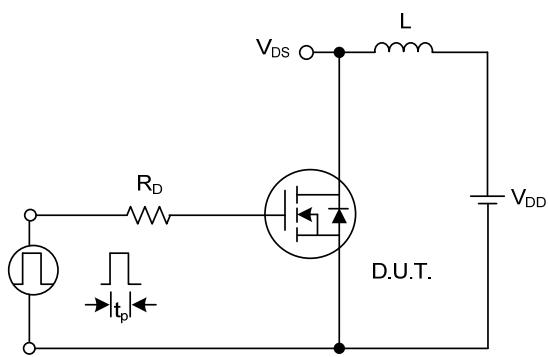
Switching Test Circuit

Switching Waveforms



Gate Charge Test Circuit

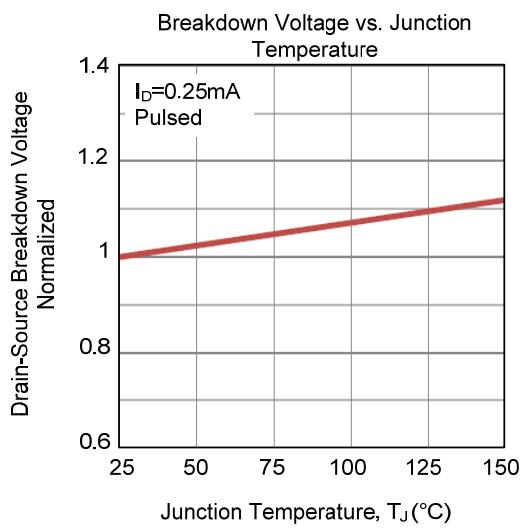
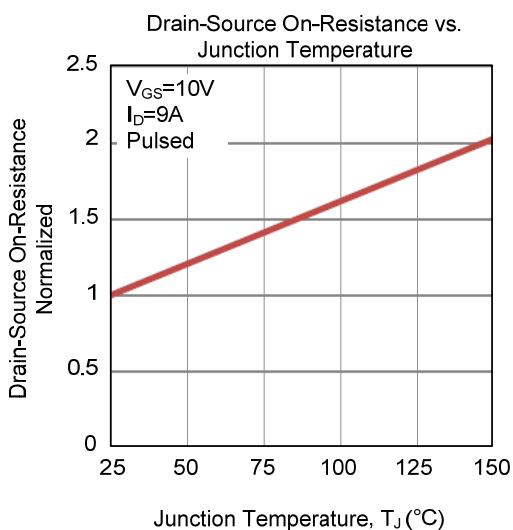
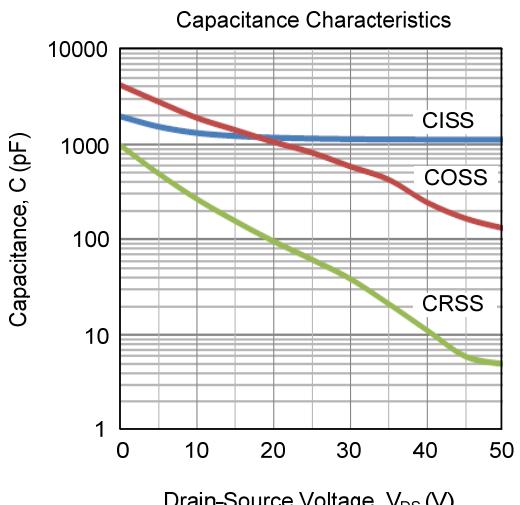
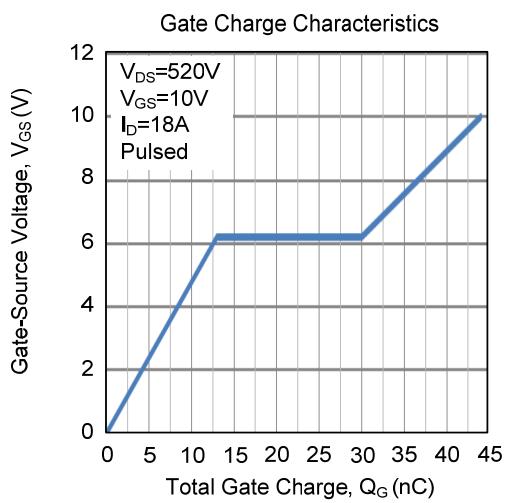
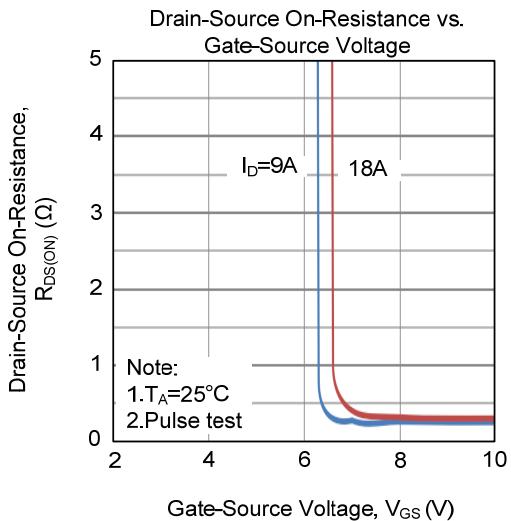
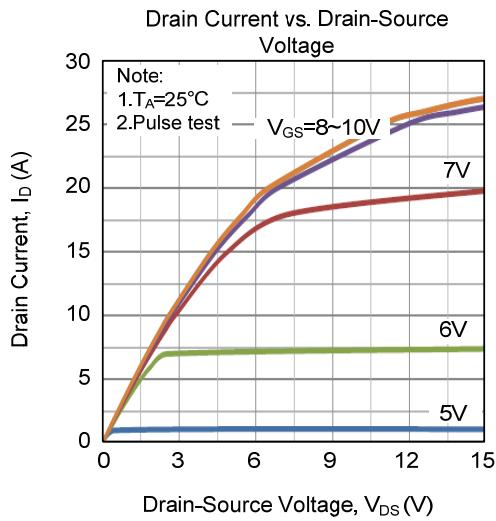
Gate Charge Waveform



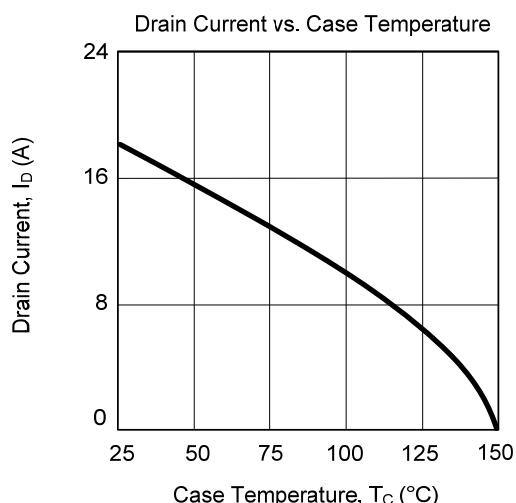
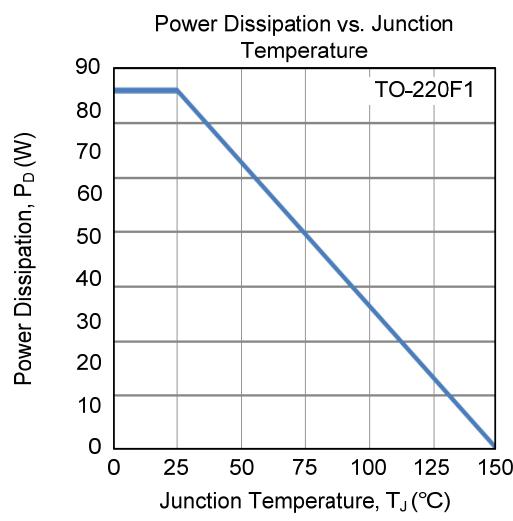
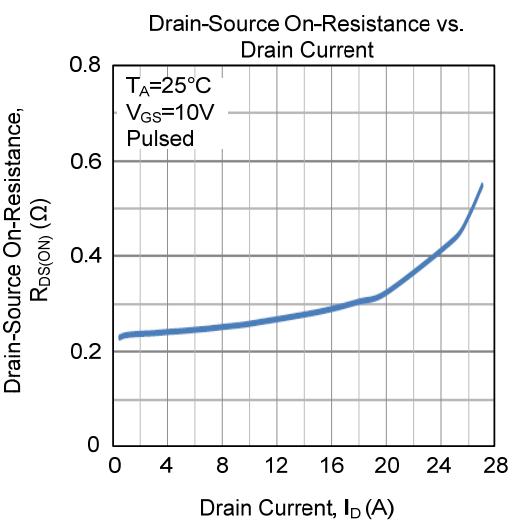
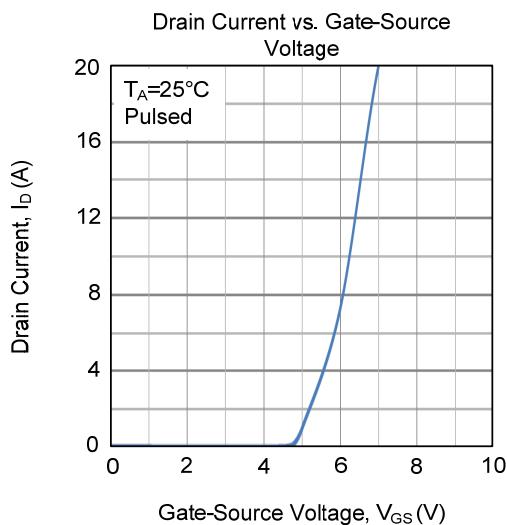
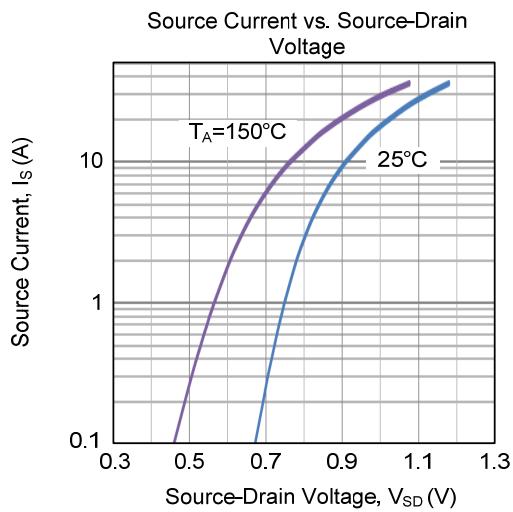
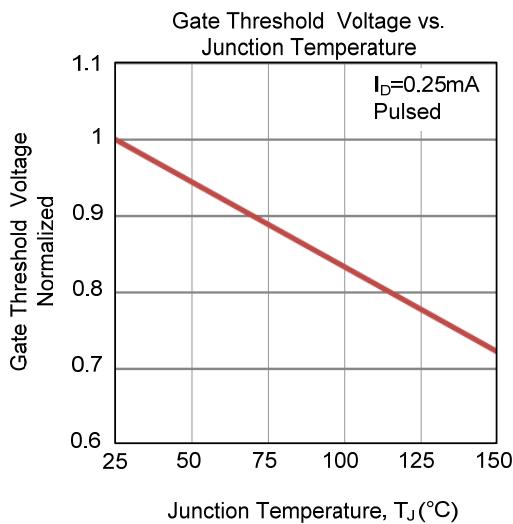
Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

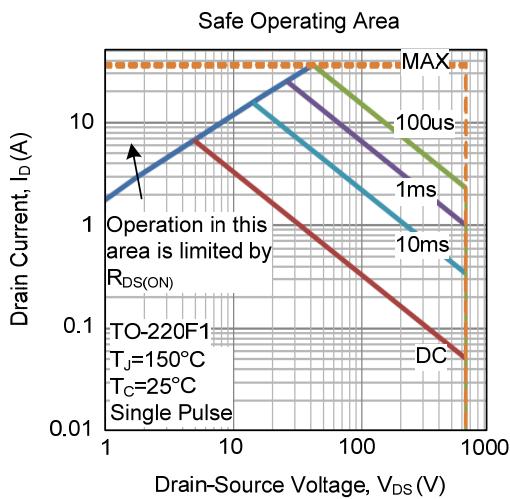
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



## ■ TYPICAL CHARACTERISTICS (Cont.)



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.